

# OPTICA APPLICATA

**Vol. XXV (95) No. 3**

PL ISSN 0078-5466

Index 367729

**A joint publication of the**

INSTITUTE OF PHYSICS,  
TECHNICAL UNIVERSITY  
OF WROCLAW,  
POLAND

&

SPIE/POLAND CHAPTER  
in association with  
SPIE—THE INTERNATIONAL SOCIETY  
FOR OPTICAL ENGINEERING

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